

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/890,490	YEO ET AL.	
		Examiner	Art Unit	Page 1 of 1
		Duc M. Nguyen	2685	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,949,832 A	09-1999	Liebetreu et al.	375/344
	B	US-6,307,443 B1	10-2001	Gabara, Thaddeus J.	333/17.1
	C	US-6,070,062 A	05-2000	Yoshida et al.	455/234.1
	D	US-6,307,442 B1	10-2001	Meyer et al.	333/17.1
	E	US-6,560,270 B1	05-2003	Hischke, Mark D.	375/136
	F	US-5,404,161 A	04-1995	Douglass et al.	725/15
	G	US-5,930,696 A	07-1999	Tzuang et al.	455/311
	H	US-6,169,569 B1	01-2001	Widmer et al.	725/111
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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